

Notice of References Cited	Application/Control No. 10/633,684		Applicant(s)/Patent Under Reexamination NAITOU ET AL.	
	Examiner Sean Weinman		Art Unit 2115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,282,495	08-2001	Kirkhart et al.	701/213
X	B	US-6,192,230	02-2001	van Bokhorst et al.	455/343.3
X	C	US-6,374,169	04-2002	Demay et al.	701/50
X	D	US-2001/0020891	09-2001	Minagawa et al.	340/5.61
X	E	US-6,356,841	03-2002	Hamrick et al.	701/213
X	F	US-6,367,022	04-2002	Gillespie et al.	713/300
X	G	US-2002/0025839	02-2002	Usui, Hisayoshi	455/574
X	H	US-5,949,812	09-1999	Turney et al.	375/130
X	I	US-6,198,995	03-2001	Settles et al.	701/29
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.